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# FPF2C8P2NL07A

## F2, 3-phase, 3-level NPC module with Press-fit / NTC

### General Description

Fairchild's new inverter modules provide low conduction and switching loss as well. And Press-Fit technology provides simple and reliable mounting. These modules are optimized for the applications such as solar inverter and UPS where a high efficiency and robust design is needed.

### Electrical Features

- High Efficiency
- Low Conduction and Switching Losses
- Field Stop IGBT for Inner and Outer Switch
- STEALTH™ Diode for Path Diode
- Built-in NTC for Temperature Monitoring

### Mechanical Features

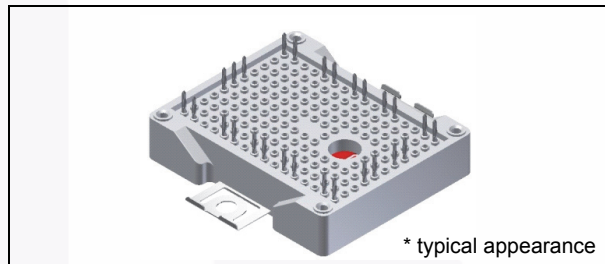
- Compact Size : F2 Package
- Press-fit Contact Technology
- Al<sub>2</sub>O<sub>3</sub> Substrate with Low Thermal Resistance

### Applications

- Solar Inverter
- UPS

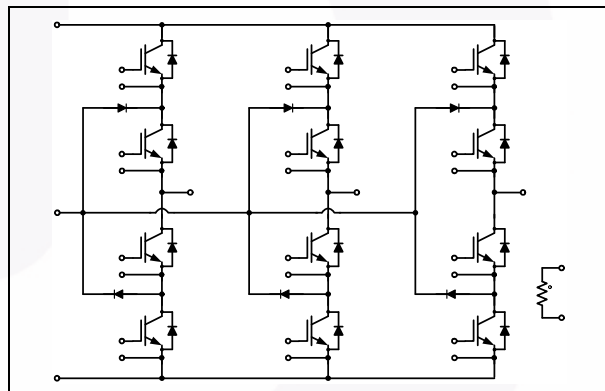
### Related Materials

- AN-4167: Mounting Guideline for F1 / F2 Modules with Press-Fit Pins



\* typical appearance

Package Code: F2



Internal Circuit Diagram

### Package Marking and Ordering Information

Device	Device Marking	Package	Packing Type	Quantity / Tray
FPF2C8P2NL07A	FPF2C8P2NL07A	F2	Tray	14

FPF2C8P2NL07A - F2, 3-phase, 3-level NPC module with Press-fit / NTC

**Absolute Maximum Ratings**  $T_C = 25^\circ\text{C}$  unless otherwise noted.

Symbol	Description	Rating	Units
<b>Outer IGBT(Q1, Q4, Q5, Q8, Q9, Q12)</b>			
$V_{CES}$	Collector-Emitter Voltage	650	V
$V_{GES}$	Gate-Emitter Voltage	$\pm 20$	V
$I_C$	Continuous Collector Current @ $T_C = 80^\circ\text{C}$ , $T_{Jmax} = 175^\circ\text{C}$	30	A
$I_{CM}$	Pulsed Collector Current limited by $T_{Jmax}$	60	A
$P_D$	Maximum Power Dissipation @ $T_C = 25^\circ\text{C}$	135	W
$T_J$	Operating Junction Temperature	- 40 to + 150	$^\circ\text{C}$
<b>Inner IGBT(Q2, Q3, Q6, Q7, Q10, Q11)</b>			
$V_{CES}$	Collector-Emitter Voltage	650	V
$V_{GES}$	Gate-Emitter Voltage	$\pm 20$	V
$I_C$	Continuous Collector Current @ $T_C = 80^\circ\text{C}$ , $T_{Jmax} = 175^\circ\text{C}$	50	A
$I_{CM}$	Pulsed Collector Current limited by $T_{Jmax}$	100	A
$P_D$	Maximum Power Dissipation @ $T_C = 25^\circ\text{C}$	174	W
$T_J$	Operating Junction Temperature	- 40 to + 150	$^\circ\text{C}$
<b>Outer - Inner IGBT Series Connection</b>			
SCWT	Short Circuit Withstand Time $V_{DC} = 300\text{ V}$ , $V_{GE} = 15\text{ V}$ $T_C = 25^\circ\text{C}$	4	$\mu\text{S}$
<b>Diode</b>			
$V_{RRM}$	Peak Repetitive Reverse Voltage	650	V
$I_F$	Continuous Forward Current @ $T_C = 80^\circ\text{C}$ , $T_{Jmax} = 175^\circ\text{C}$	15	A
$I_{FM}$	Maximum Forward Current	30	A
$P_D$	Maximum Power Dissipation @ $T_C = 25^\circ\text{C}$	100	W
$T_J$	Operating Junction Temperature	- 40 to + 150	$^\circ\text{C}$
<b>Module</b>			
$T_{STG}$	Storage Temperature	- 40 to + 125	$^\circ\text{C}$
$V_{ISO}$	Isolation Voltage @ AC 1 min.	2500	V
Iso_Material	Internal Isolation Material	$\text{Al}_2\text{O}_3$	
$T_{MOUNT}$	Mounting Torque	2.0 to 5.0	Nm
Creepage	Terminal to Heat Sink	11.5	mm
	Terminal to Terminal	6.3	mm
Clearance	Terminal to Heat Sink	10.0	mm
	Terminal to Terminal	5.0	mm

**Electrical Characteristics**  $T_C = 25^\circ\text{C}$  unless otherwise noted.

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units	
<b>Outer IGBT</b>							
<b>Off Characteristics</b>							
$BV_{CES}$	Collector-Emitter Breakdown Voltage	$V_{GE} = 0\text{ V}, I_C = 1\text{ mA}$	650	-	-	V	
$I_{CES}$	Collector Cut-off Current	$V_{CE} = V_{CES}, V_{GE} = 0\text{ V}$	-	-	250	$\mu\text{A}$	
$I_{GES}$	Gate-Emitter Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0\text{ V}$	-	-	2	$\mu\text{A}$	
<b>On Characteristics</b>							
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_C = 30\text{ mA}$	4.5	5.6	6.7	V	
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C = 30\text{ A}, V_{GE} = 15\text{ V}$	-	1.55	2.2	V	
		$I_C = 30\text{ A}, V_{GE} = 15\text{ V} @ T_C = 125^\circ\text{C}$	-	1.75	-	V	
		$I_C = 60\text{ A}, V_{GE} = 15\text{ V}$	-	2.13	-	V	
<b>Switching Characteristics</b>							
$t_{d(on)}$	Turn-On Delay Time	$V_{CC} = 300\text{ V}$ $I_C = 30\text{ A}$ $V_{GE} = \pm 15\text{ V}$ $R_G = 20\ \Omega$ Inductive Load $T_C = 25^\circ\text{C}$	-	33	-	ns	
$t_r$	Rise Time		-	43	-	ns	
$t_{d(off)}$	Turn-Off Delay Time		-	197	-	ns	
$t_f$	Fall Time		-	17	-	ns	
$E_{ON}$	Turn-On Switching Loss per Pulse		-	0.68	-	mJ	
$E_{OFF}$	Turn-Off Switching Loss per Pulse		-	0.38	-	mJ	
$t_{d(on)}$	Turn-On Delay Time		$V_{CC} = 300\text{ V}$ $I_C = 30\text{ A}$ $V_{GE} = \pm 15\text{ V}$ $R_G = 20\ \Omega$ Inductive Load $T_C = 125^\circ\text{C}$	-	29	-	ns
$t_r$	Rise Time			-	50	-	ns
$t_{d(off)}$	Turn-Off Delay Time			-	205	-	ns
$t_f$	Fall Time			-	25	-	ns
$E_{ON}$	Turn-On Switching Loss per Pulse	-		0.86	-	mJ	
$E_{OFF}$	Turn-Off Switching Loss per Pulse	-		0.52	-	mJ	
$Q_g$	Total Gate Charge	$V_{CC} = 300\text{ V}, I_C = 30\text{ A}, V_{GE} = \pm 15\text{ V}$		-	0.26	-	$\mu\text{C}$
$R_{\theta JC}$	Thermal Resistance of Junction to Case	per Chip		-	-	1.11	$^\circ\text{C/W}$
<b>Inner IGBT</b>							
<b>Off Characteristics</b>							
$BV_{CES}$	Collector-Emitter Breakdown Voltage	$V_{GE} = 0\text{ V}, I_C = 1\text{ mA}$	650	-	-	V	
$I_{CES}$	Collector Cut-off Current	$V_{CE} = V_{CES}, V_{GE} = 0\text{ V}$	-	-	250	$\mu\text{A}$	
$I_{GES}$	Gate-Emitter Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0\text{ V}$	-	-	2	$\mu\text{A}$	
<b>On Characteristics</b>							
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_C = 50\text{ mA}$	4.5	5.6	6.7	V	
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C = 50\text{ A}, V_{GE} = 15\text{ V}$	-	1.65	2.3	V	
		$I_C = 50\text{ A}, V_{GE} = 15\text{ V} @ T_C = 125^\circ\text{C}$	-	1.95	-	V	
		$I_C = 100\text{ A}, V_{GE} = 15\text{ V}$	-	2.49	-	V	
<b>Switching Characteristics</b>							
$t_{d(on)}$	Turn-On Delay Time	$V_{CC} = 300\text{ V}$ $I_C = 50\text{ A}$ $V_{GE} = \pm 15\text{ V}$ $R_G = 15\ \Omega$ Inductive Load $T_C = 25^\circ\text{C}$	-	41	-	ns	
$t_r$	Rise Time		-	65	-	ns	
$t_{d(off)}$	Turn-Off Delay Time		-	233	-	ns	
$t_f$	Fall Time		-	18	-	ns	
$E_{ON}$	Turn-On Switching Loss per Pulse		-	0.87	-	mJ	
$E_{OFF}$	Turn-Off Switching Loss per Pulse		-	0.77	-	mJ	
$t_{d(on)}$	Turn-On Delay Time		$V_{CC} = 300\text{ V}$ $I_C = 50\text{ A}$ $V_{GE} = \pm 15\text{ V}$ $R_G = 15\ \Omega$ Inductive Load $T_C = 125^\circ\text{C}$	-	39	-	ns
$t_r$	Rise Time			-	76	-	ns
$t_{d(off)}$	Turn-Off Delay Time			-	243	-	ns
$t_f$	Fall Time			-	20	-	ns
$E_{ON}$	Turn-On Switching Loss per Pulse	-		0.99	-	mJ	
$E_{OFF}$	Turn-Off Switching Loss per Pulse	-		0.93	-	mJ	
$Q_g$	Total Gate Charge	$V_{CC} = 300\text{ V}, I_C = 50\text{ A}, V_{GE} = \pm 15\text{ V}$		-	0.39	-	nC
$R_{\theta JC}$	Thermal Resistance of Junction to Case	per Chip		-	-	0.86	$^\circ\text{C/W}$

**Electrical Characteristics**  $T_C = 25^\circ\text{C}$  unless otherwise noted.

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
<b>Diode</b>						
$V_{FM}$	Diode Forward Voltage	$I_F = 15\text{ A}$	-	2.55	3.4	V
		$I_F = 15\text{ A @ }T_C = 125^\circ\text{C}$	-	1.78	-	V
$I_R$	Reverse Leakage Current	$V_R = 650\text{ V}$	-	-	250	$\mu\text{A}$
$t_{rr}$	Reverse Recovery Time	$V_R = 300\text{ V}, I_F = 15\text{ A}$ $di_F / dt = 700\text{ A/us}$ $T_C = 25^\circ\text{C}$	-	23	-	ns
$I_{rr}$	Reverse Recovery Current		-	9.9	-	A
$Q_{rr}$	Reverse Recovery Charge		-	113	-	nC
$t_{rr}$	Reverse Recovery Time	$V_R = 300\text{ V}, I_F = 15\text{ A}$ $di_F / dt = 700\text{ A/us}$ $T_C = 125^\circ\text{C}$	-	49	-	ns
$I_{rr}$	Reverse Recovery Current		-	15.2	-	A
$Q_{rr}$	Reverse Recovery Charge		-	366	-	nC
$R_{\theta JC}$	Thermal Resistance of Junction to Case	per Chip	-	-	1.44	$^\circ\text{C/W}$
<b>NTC_ Thermistor</b>						
$R_{NTC}$	Rated Resistance	$T_C = 25^\circ\text{C}$	-	5.0	-	k $\Omega$
		$T_C = 100^\circ\text{C}$	-	493	-	$\Omega$
	Tolerance	$T_C = 25^\circ\text{C}$	-5	-	+5	%
$P_D$	Power Dissipation	$T_C = 25^\circ\text{C}$	-	-	20	mW
$B_{Value}$	B-Constant	$B_{25/50}$	-	3375	-	K
		$B_{25/100}$	-	3436	-	K

## Typical Performance Characteristic

Fig 1. Typical Output Characteristics  
- Outer IGBT

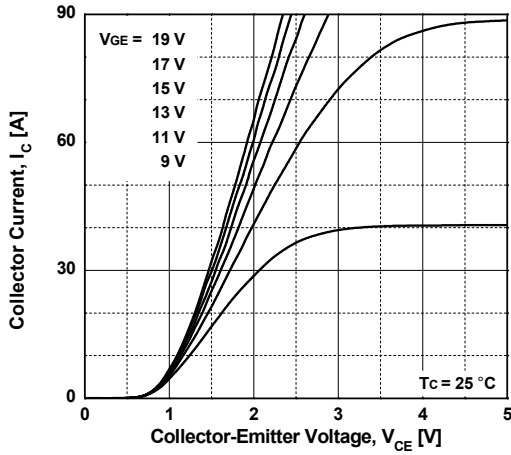


Fig 2. Typical Output Characteristics  
- Outer IGBT

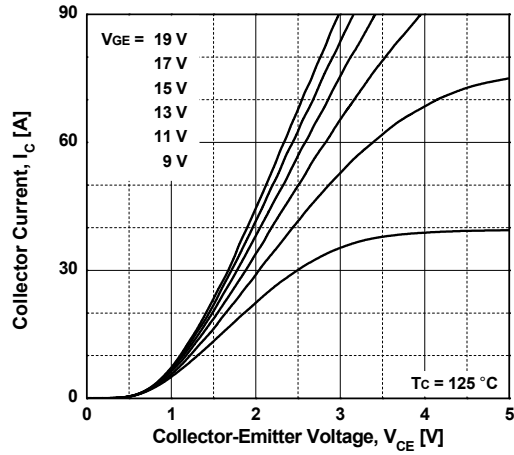


Fig 3. Typical Saturation Voltage Characteristics  
- Outer IGBT

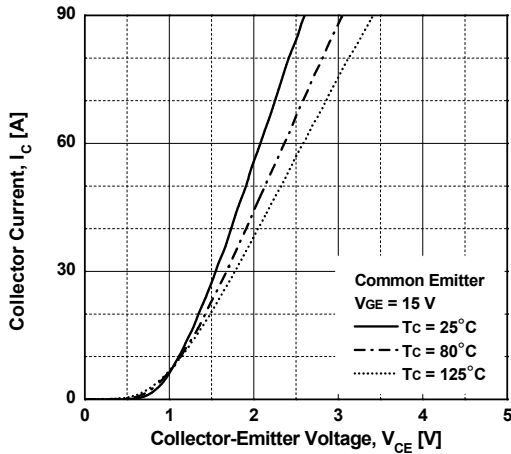


Fig 4. Switching Loss vs. Collector Current  
- Outer IGBT

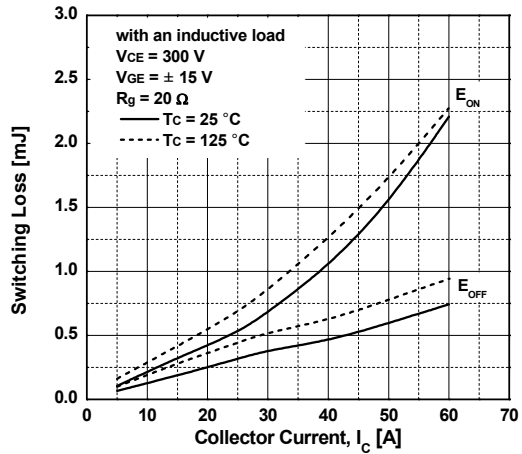


Fig 5. Switching Loss vs. Gate Resistance  
- Outer IGBT

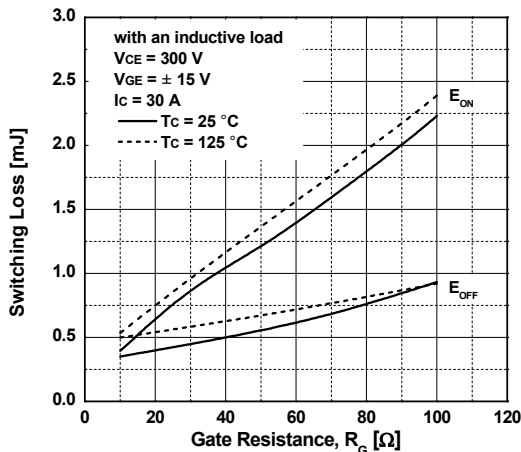
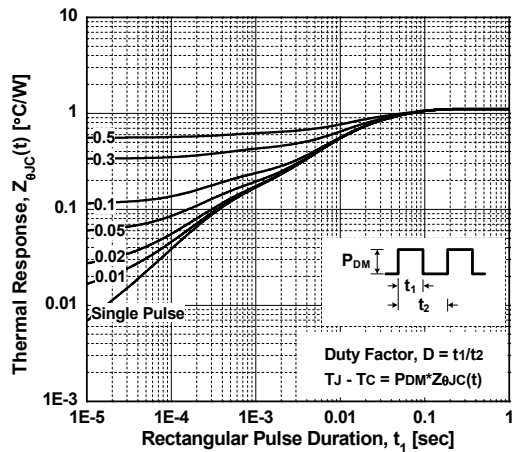
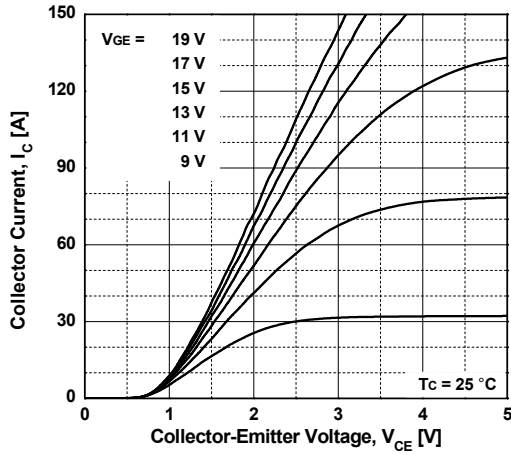


Fig 6. Transient Thermal Impedance  
- Outer IGBT

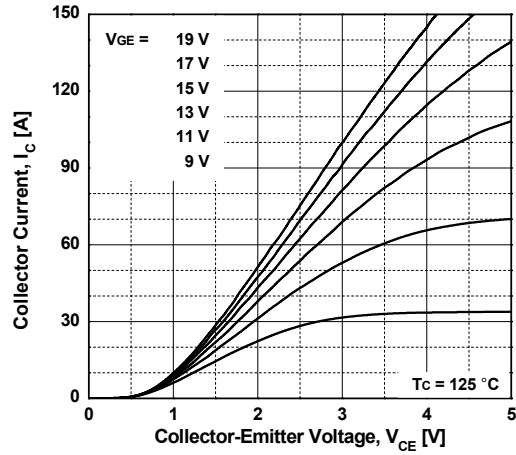


## Typical Performance Characteristic

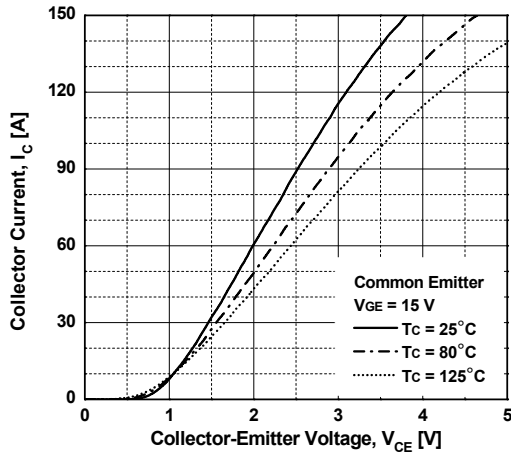
**Fig 7. Typical Output Characteristics - Inner IGBT**



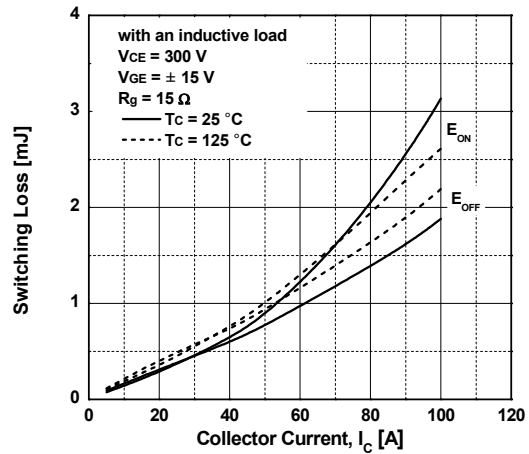
**Fig 8. Typical Output Characteristics - Inner IGBT**



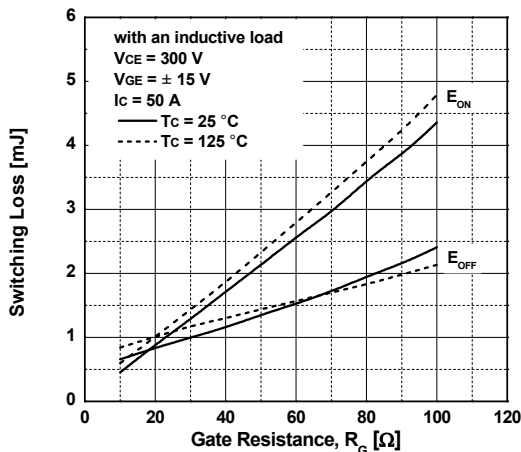
**Fig 9. Typical Saturation Voltage Characteristics - Inner IGBT**



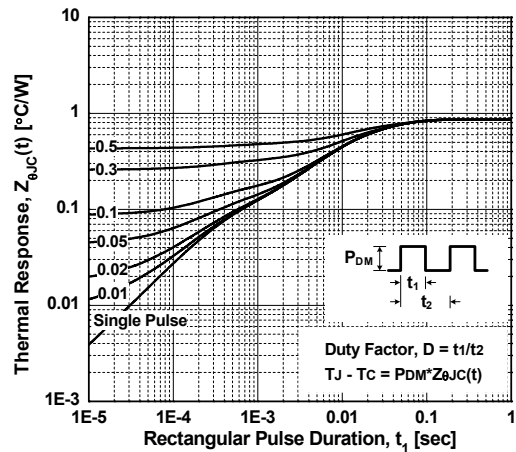
**Fig 10. Switching Loss vs. Collector Current - Inner IGBT**



**Fig 11. Switching Loss vs. Gate Resistance - Inner IGBT**



**Fig 12. Transient Thermal Impedance - Inner IGBT**



### Typical Performance Characteristic

Fig 13. Reverse Bias Safe Operating Area (RBSOA) - Outer IGBT

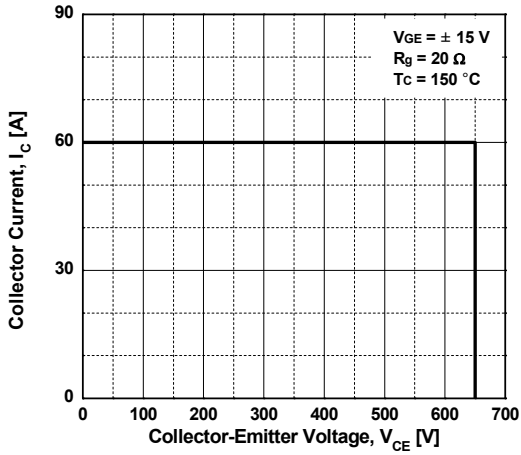


Fig 14. Reverse Bias Safe Operating Area (RBSOA) - Inner IGBT

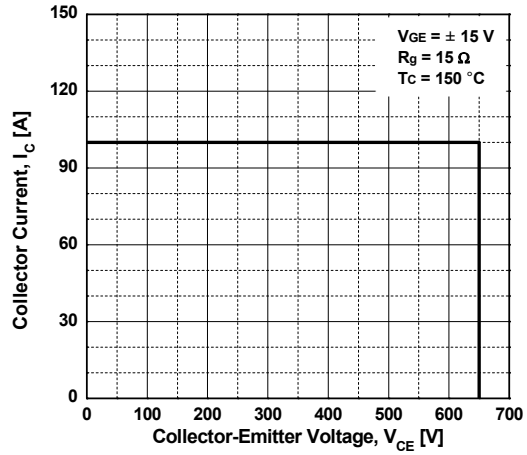


Fig 15. Typical Forward Voltage Drop - Diode

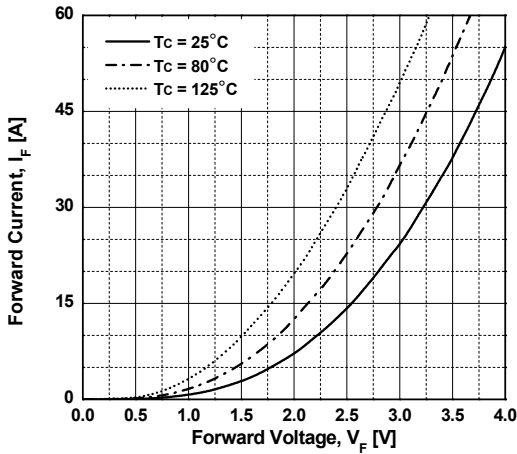


Fig 16. Reverse Recovery Energy vs. Forward Current - Diode

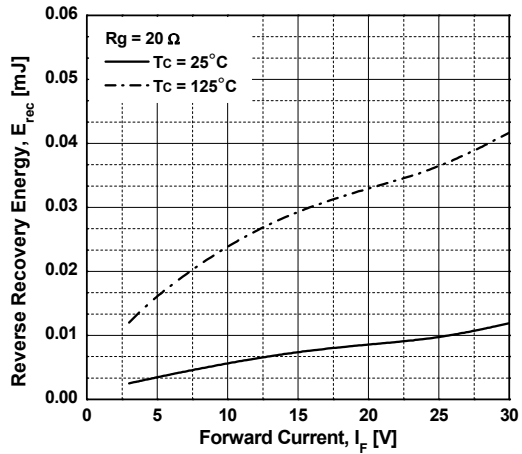


Fig 17. Reverse Recovery Energy vs. Gate Resistance - Diode

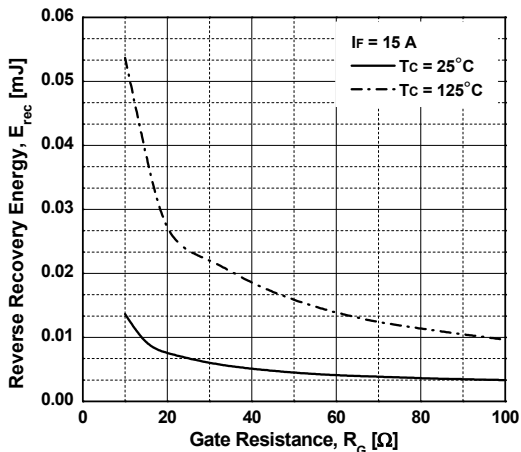
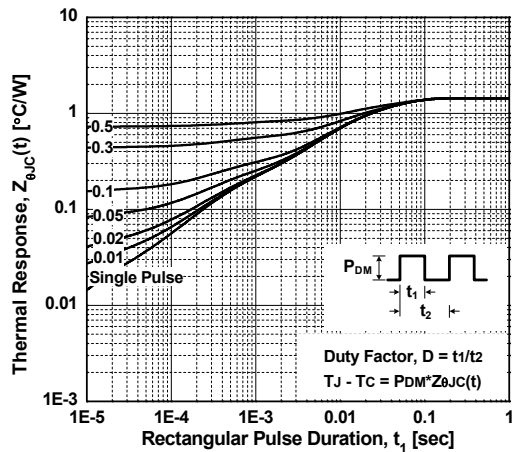
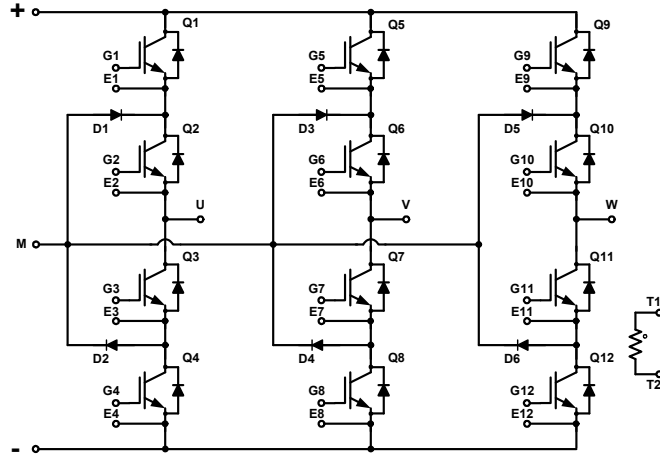


Fig 18. Transient Thermal Impedance - Diode

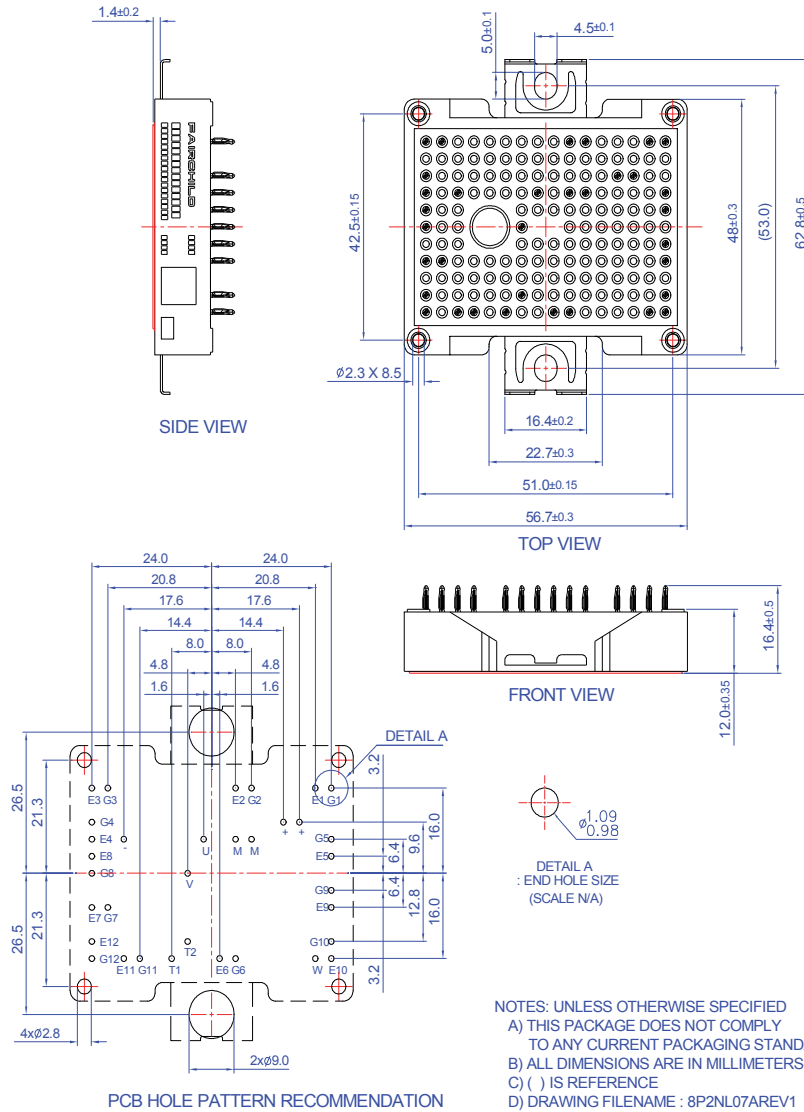




### Internal Circuit Diagram



### Package Outlines [mm]



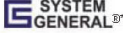




- PIN-GRID 3.2mm  
 - TOLERANCE OF PCB HOLE PATTERN  $\pm 0.1$





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**PRODUCT STATUS DEFINITIONS**

**Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

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